
Information technology — Big data — Overview and vocabulary

*Technologies de l'information — Mégadonnées — Vue d'ensemble et
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Contents

Page

Foreword	iv
Introduction	v
1 Scope	1
2 Normative references	1
3 Terms, definitions and abbreviated terms	1
3.1 Terms and definitions.....	1
3.2 Abbreviated terms.....	6
4 Key characteristics of big data	6
4.1 General.....	6
4.2 Key data characteristics.....	6
4.2.1 Data volume.....	6
4.2.2 Data velocity.....	6
4.2.3 Data variety.....	6
4.2.4 Data variability.....	6
4.3 Key data processing characteristics.....	7
4.3.1 Data science.....	7
4.3.2 Data volatility.....	7
4.3.3 Data veracity.....	7
4.3.4 Benefit.....	7
4.3.5 Data visualization.....	7
4.3.6 Structured and unstructured data.....	7
4.3.7 Scaling.....	7
4.3.8 Distributed file system.....	8
4.3.9 Distributed data processing.....	8
4.3.10 Non-relational databases.....	8
Annex A (informative) Cross-cutting concepts of big data	9
Bibliography	12

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